

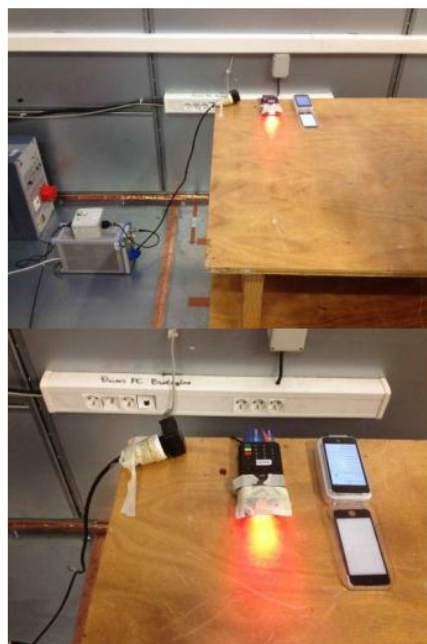
## CONDUCTED AND RADIATED MEASUREMENT PHOTO

FCCID: XKB-IMP3X2

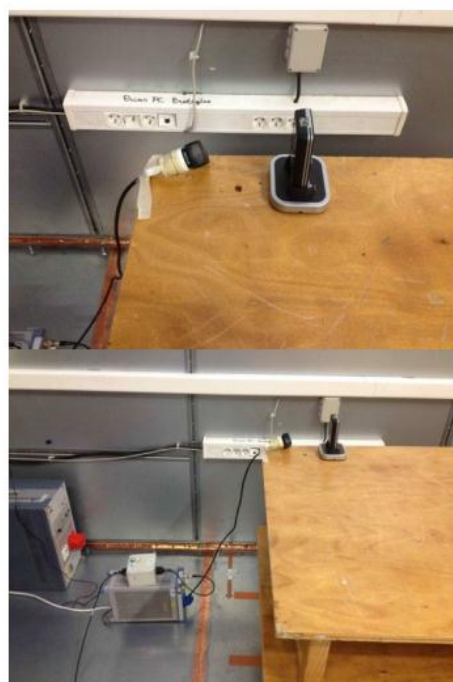
### 1.1 Conducted emission



Test setup in configuration 1 :



Test setup in configuration 2





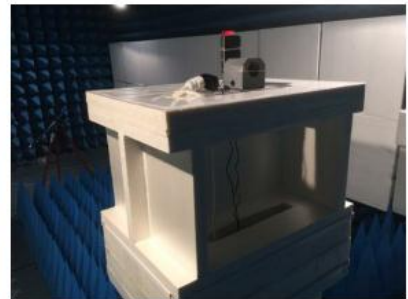
LCIE

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## 1.2 Radiated emissions



*General Test setup on OATS worst case presented (30MHz to 1GHz, configuration 1, same setup for configuration 2)*



*General Test setup in anechoic chamber worst case presented (1GHz to 6GHz, configuration 1, same setup for configuration 2)*